



## UF830

## Power MOSFET

### 4.5A, 500V, 1.5Ω, N-CANNEL POWER MOSFET

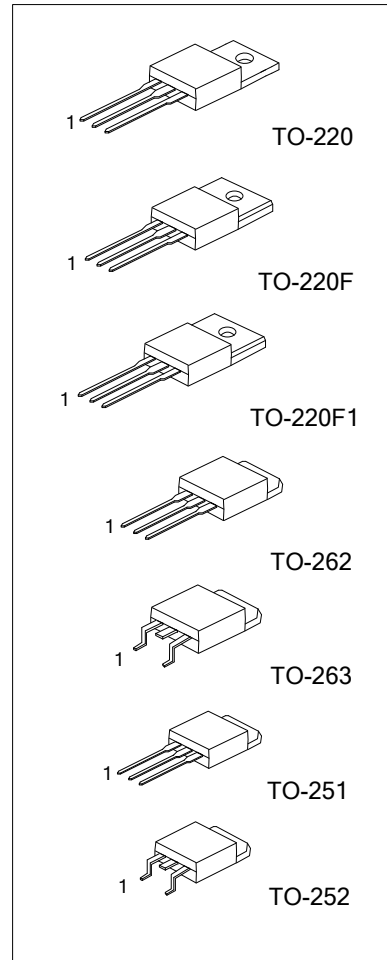
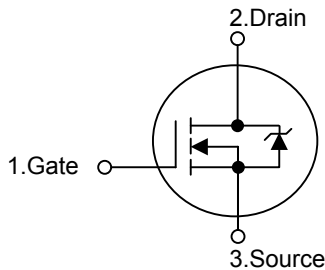
#### DESCRIPTION

The N-Channel enhancement mode silicon gate power MOSFET is designed for high voltage, high speed power switching applications such as switching regulators, switching converters, solenoid, motor drivers, relay drivers.

#### FEATURES

- \* 4.5A, 500V,  $R_{DS(ON)}=1.5\Omega$
- \* Single Pulse Avalanche Energy Rated
- \* Rugged- SOA is Power Dissipation Limited
- \* Fast Switching Speeds
- \* Linear Transfer Characteristics
- \* High Input Impedance

#### SYMBOL



#### ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UF830L-TA3-T	UF830G-TA3-T	TO-220	G	D	S	Tube
UF830L-TF3-T	UF830G-TF3-T	TO-220F	G	D	S	Tube
UF830L-TF1-T	UF830G-TF1-T	TO-220F1	G	D	S	Tube
UF830L-TM3-T	UF830G-TM3-T	TO-251	G	D	S	Tube
UF830L-TN3-R	UF830G-TN3-R	TO-252	G	D	S	Tape Reel
UF830L-T2Q-T	UF830G-T2Q-T	TO-262	G	D	S	Tube
UF830L-TQ2-R	UF830G-TQ2-R	TO-263	G	D	S	Tape Reel
UF830L-TQ2-T	UF830G-TQ2-T	TO-263	G	D	S	Tube

<p>UF830L-TA3-T</p> <p>(1)Packing Type (2)Package Type (3)Lead Free</p>	<p>(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TF3: TO-220F, TF1: TO-220F1 TM3: TO-251, TN3: TO-252, T2Q: TO-262, TQ2: TO-263 (3) G: Halogen Free, L: Lead Free</p>
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## ■ ABSOLUTE MAXIMUM RATINGS (Ta = 25°C, Unless Otherwise Specified.)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain to Source Voltage (T <sub>J</sub> =25°C ~125°C)		V <sub>DS</sub>	500	V
Drain to Gate Voltage (R <sub>GS</sub> =20kΩ, T <sub>J</sub> =25°C ~125°C)		V <sub>DGR</sub>	500	V
Gate to Source Voltage		V <sub>GS</sub>	±30	V
Drain Current	Continuous	I <sub>D</sub>	4.5	A
	Pulsed	I <sub>DM</sub>	18	A
Power Dissipation (T <sub>C</sub> = 25°C)	TO-220/TO-262/TO-263	P <sub>D</sub>	73	W
	TO-220F/ TO-220F1		38	W
	TO-251/TO-252		46	W
Single Pulse Avalanche Energy Rating (Note 2)		E <sub>AS</sub>	300	mJ
Junction Temperature		T <sub>J</sub>	+150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. V<sub>DD</sub>=50V, starting T<sub>J</sub>=25°C, L=25mH, R<sub>G</sub>=25Ω, peak I<sub>AS</sub>=4.5A

## ■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-262/TO-263	θ <sub>JA</sub>	62.5	°C/W
	TO-220F/ TO-220F1		62.5	°C/W
	TO-251/TO-252		100.3	°C/W
Junction to Case	TO-220/TO-262/TO-263	θ <sub>Jc</sub>	1.71	°C/W
	TO-220F/ TO-220F1		3.31	°C/W
	TO-251/TO-252		2.7	°C/W

## ■ ELECTRICAL SPECIFICATIONS (Ta =25°C, unless otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	500			V
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250μA	2.0		4.0	V
On-State Drain Current (Note 1)	I <sub>D(ON)</sub>	V <sub>DS</sub> >I <sub>D(ON)</sub> ×R <sub>DS(ON)MAX</sub> , V <sub>GS</sub> =10V	4.5			A
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = Rated BV <sub>DSS</sub> , V <sub>GS</sub> =0V			25	μA
		V <sub>DS</sub> =0.8×Rated BV <sub>DSS</sub>			250	μA
		V <sub>GS</sub> =0V, T <sub>J</sub> = 125°C				
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±30V			±100	nA
Static Drain-Source On-State Resistance (Note 2)	R <sub>DS(ON)</sub>	I <sub>D</sub> =2.5A, V <sub>GS</sub> =10V		1.3	1.5	Ω
Forward Transconductance (Note 1)	g <sub>FS</sub>	V <sub>DS</sub> ≥ 10V, I <sub>D</sub> =2.7A	2.5	4.2		S
Turn-On Delay Time	t <sub>D(ON)</sub>	V <sub>DD</sub> =250V, I <sub>D</sub> ≈4.5A R <sub>GS</sub> =12Ω, R <sub>L</sub> =54Ω (Note 2)		10	17	ns
Turn-On Rise Time	t <sub>r</sub>			15	23	ns
Turn-Off Delay Time	t <sub>D(OFF)</sub>			33	53	ns
Turn-Off Fall Time	t <sub>f</sub>			16	23	ns
Total Gate Charge	Q <sub>G</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =4.5A		22	32	nC
Gate-Source Charge	Q <sub>GS</sub>	V <sub>DS</sub> =0.8×Rated BV <sub>DSS</sub>		3.5		nC
Gate-Drain Charge	Q <sub>GD</sub>	I <sub>G(REF)</sub> =1.5mA (Note 3)		11		nC
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz		600		pF
Output Capacitance	C <sub>OSS</sub>			100		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			20		pF

Note: 1. Pulse Test: Pulse width≤300μs, Duty Cycle≤2%.

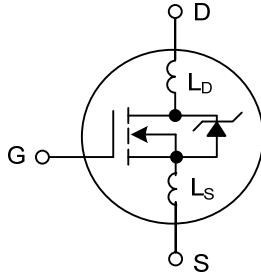
2. MOSFET Switching Times are Essentially Independent of Operating Temperature.

3. Gate Charge is Essentially Independent of Operating Temperature.

## INTERNAL PACKAGE INDUCTANCE

PARAMETER	SYMBOL	MIN	TYP	MAX	UNIT
<b>Internal Drain Inductance</b>					
Measured from the contact screw on tab to center of die	$L_D$		3.5		nH
Measured from the drain lead(6mm from package) to center of die			4.5		nH
<b>Internal Source Inductance</b>					
Measured from the source lead(6mm from header) to source bond pad	$L_S$		7.5		nH

**Remark:** Modified MOSFET symbol showing the internal devices inductances as below.

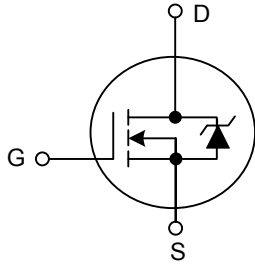


## SOURCE TO DRAIN DIODE SPECIFICATIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Source to Drain Diode Voltage (Note 1)	$V_{SD}$	$T_J=25^{\circ}C, I_{SD}=4.5A, V_{GS}=0V$			1.6	V
Continuous Source to Drain Current	$I_{SD}$	Note 2			5.5	A
Pulse Source to Drain Current	$I_{SDM}$				18	A
Reverse Recovery Time	$t_{RR}$	$T_J=25^{\circ}C, I_{SD}=4.5A, dI/dt=100A/\mu s$	180	350	760	ns
Reverse Recovery Charge	$Q_{RR}$	$T_J=25^{\circ}C, I_{SD}=4.5A, dI/dt=100A/\mu s$	0.96	2.2	4.3	$\mu C$

NOTE : 1. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .

2. Modified MOSFET symbol showing the integral reverse P-N junction diode as below.



■ TEST CIRCUITS AND WAVEFORMS

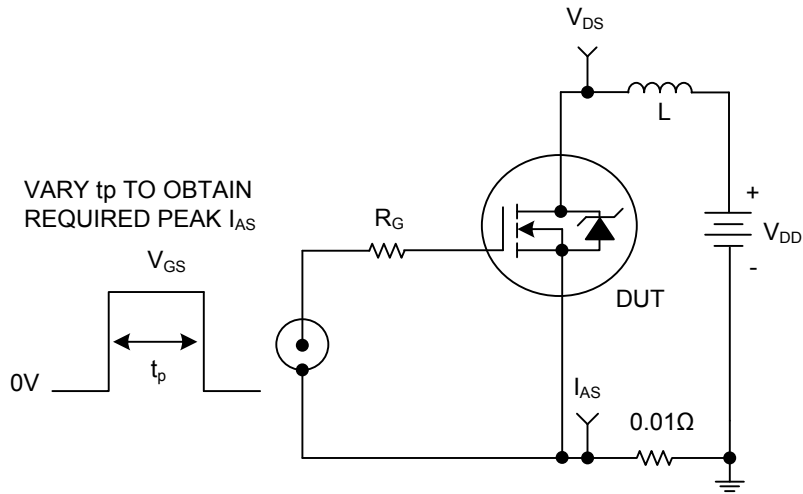


FIG 1. UNCLAMPED ENERGY TEST CIRCUIT

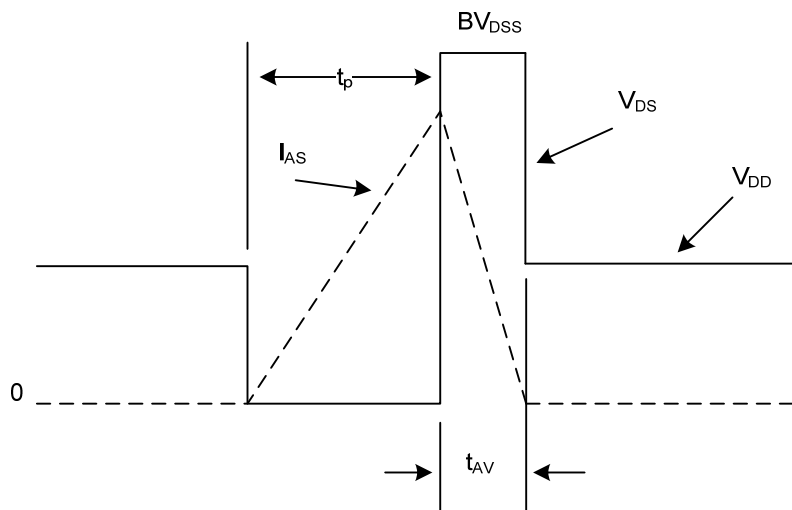


FIG 2. UNCLAMPED ENERGY WAVEFORMS

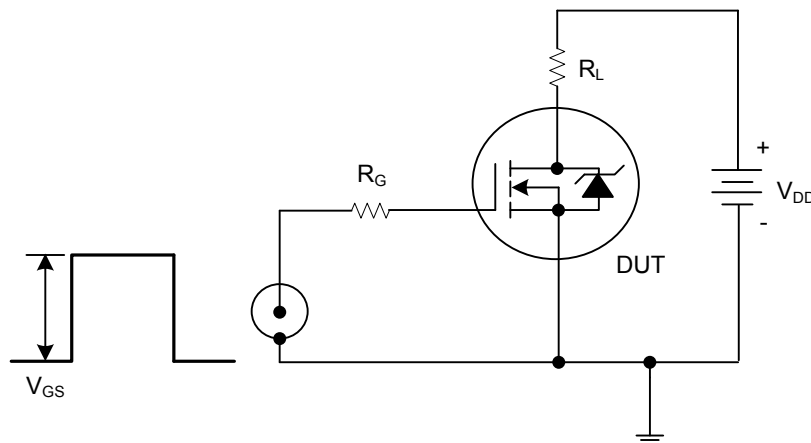


FIG 3. SWITCHING TIME TEST CIRCUIT

■ TEST CIRCUITS AND WAVEFORMS (Cont.)

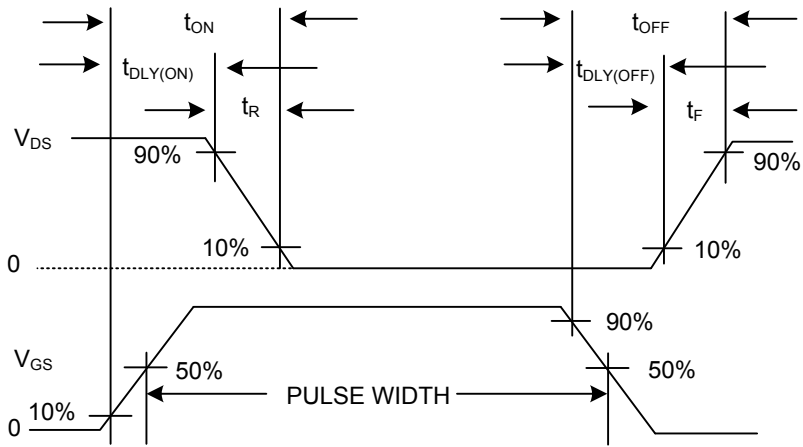


FIG 4. RESISTIVE SWITCHING WAVEFORMS

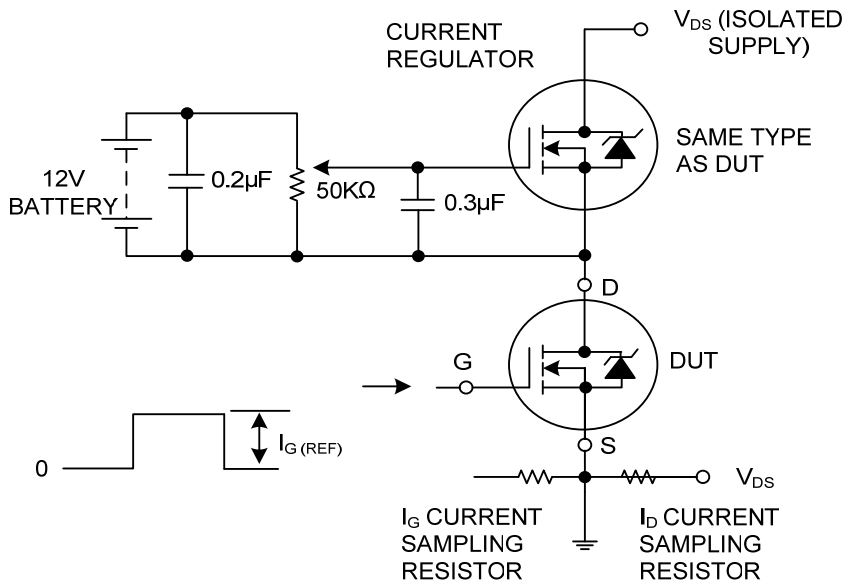


FIG 5. GATE CHARGE TEST CIRCUIT

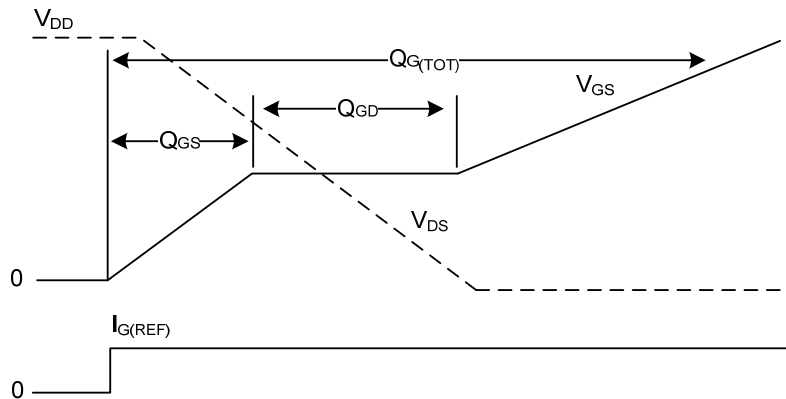
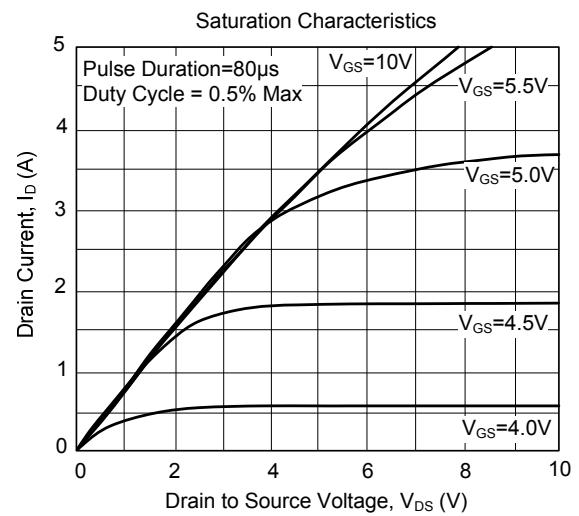
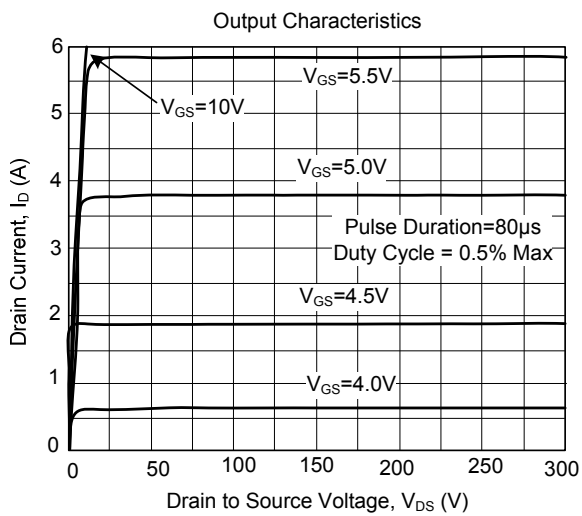
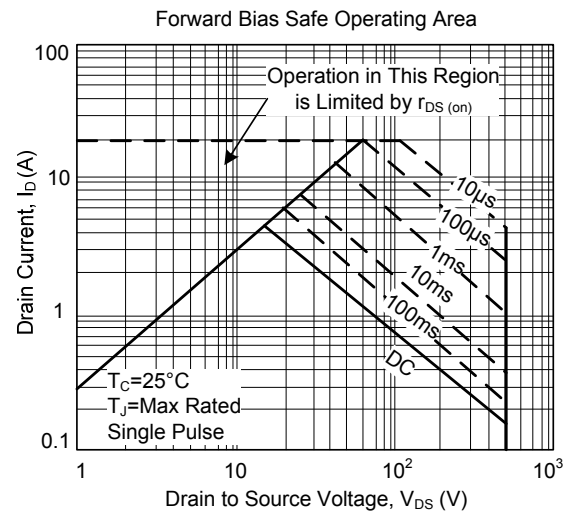
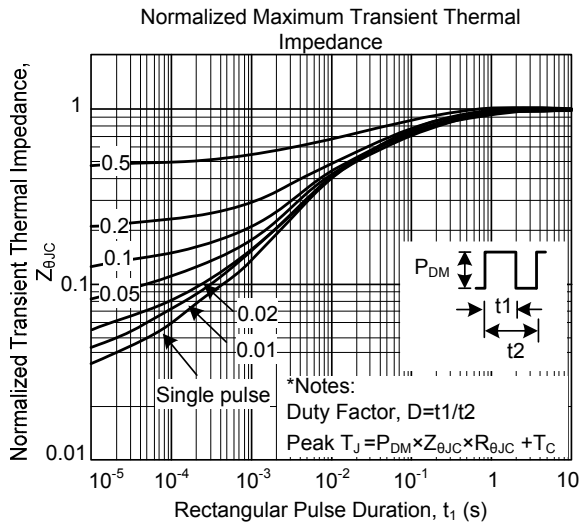
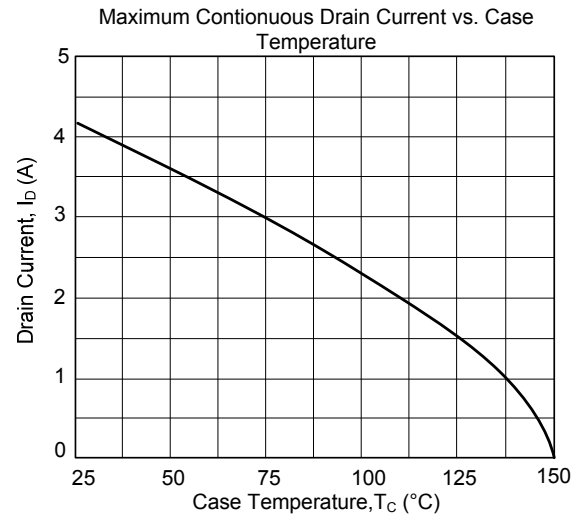
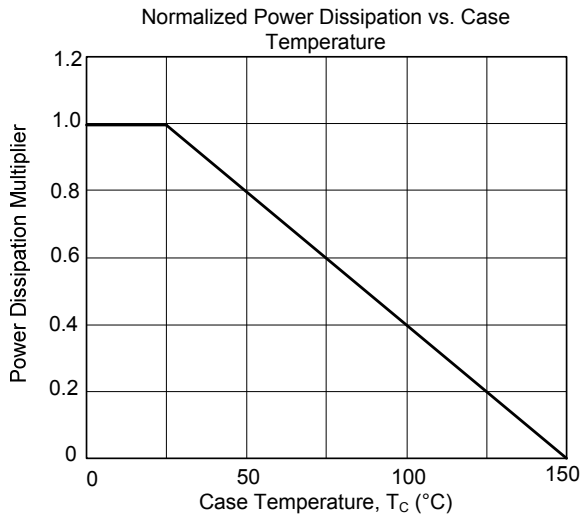
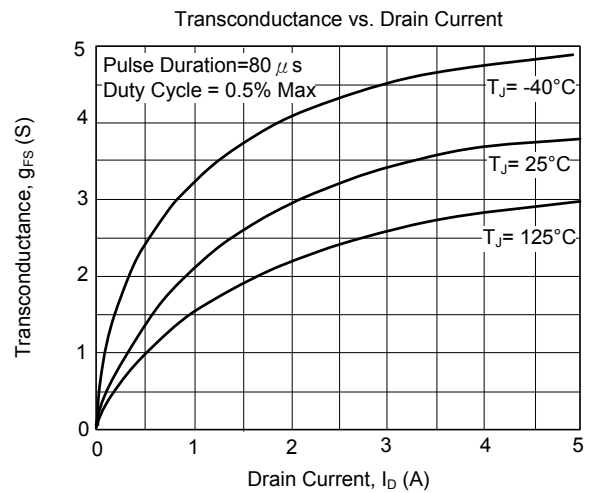
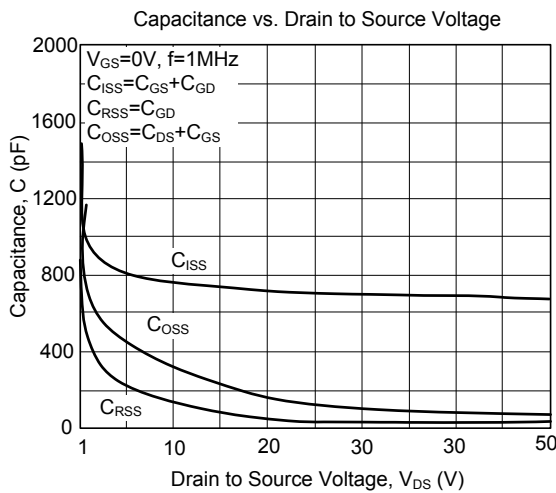
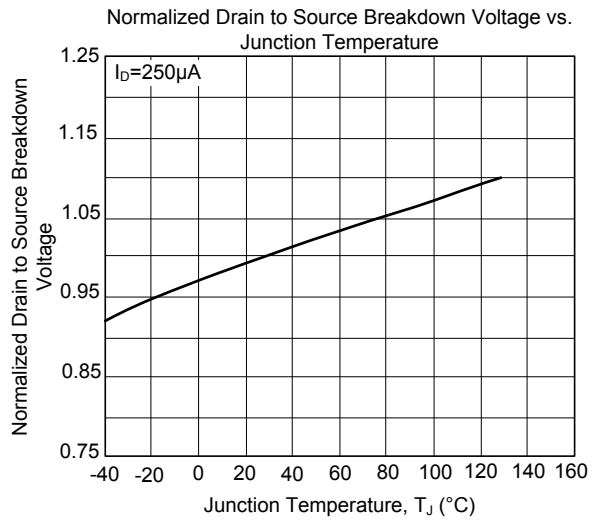
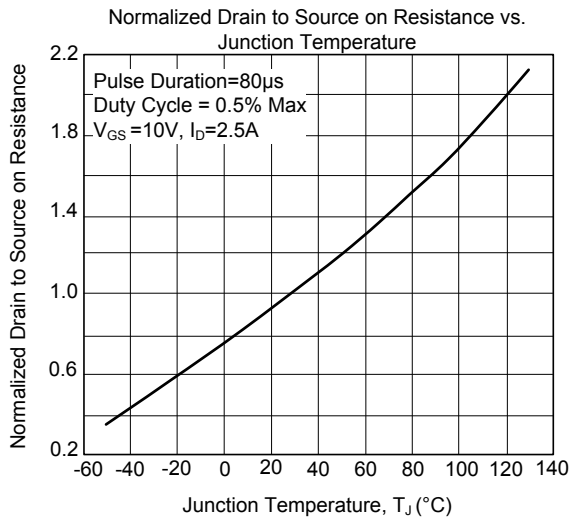
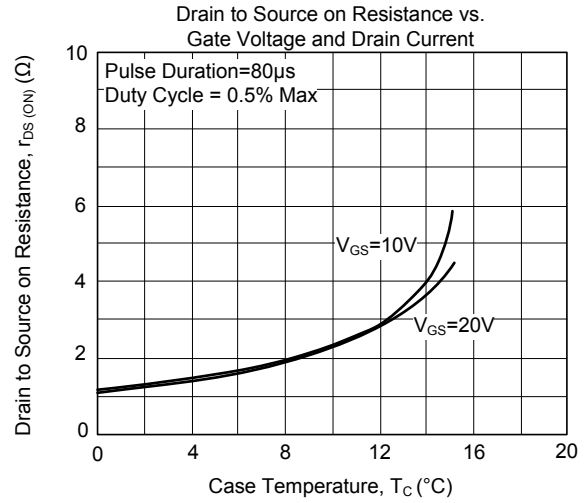
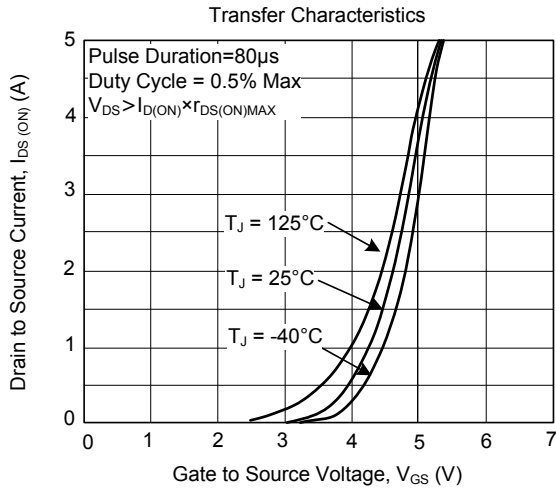


FIG 6. GATE CHARGE WAVEFORMS

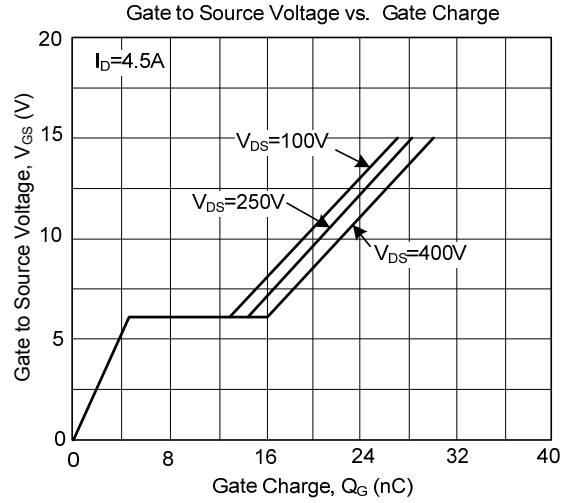
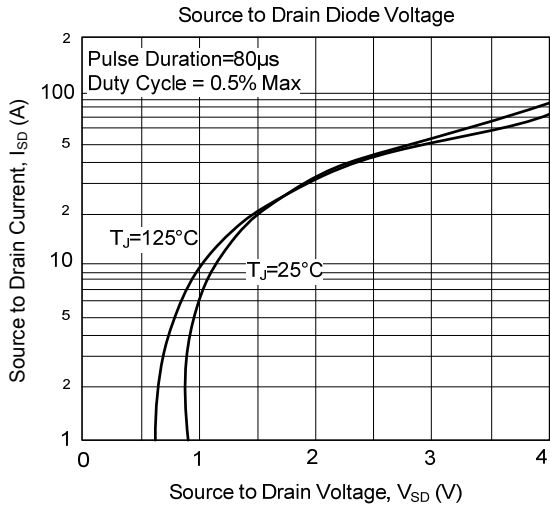
## TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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